

IEC QUALITY ASSESSMENT SYSTEM (IECQ)

covering Electronic Components, Assemblies, Related Materials and Processes

For rules and details of the IECQ visit www.iecq.org

Issue Date:

IECQ Certificate of Conformity Manufacturer

IECQ Certificate No.: **IECQ-P LCIE 13.0004** Issue No.: Status: Current IECQ-P LCIE 13.0004 Issue 5 2014/02/27

Supersedes: 2023/02/27 Org Issue: CB Reference No.: **Expiration:** 2026/02/26 14598494-777644

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The organization has developed and implemented procedures and related processes which have been assessed by the IECQ Certification Body issuing this certificate and found to comply with the applicable requirements of the IECQ Approved Process Scheme which is in accordance with the Basic Rules IECQ 01 "Rules of Procedure", IECQ 03-1 "IECQ General Requirements for all Schemes" & IECQ 03-2 "IECQ Approved Process Scheme" of the IEC Quality Assessment System for Electronic Components (IECQ), and in respect of standard(s) or specification(s):

• CECC 32 101-801 {Ed.1, 1988} Fixed multilayer ceramic chip capacitors

Process Manual Reference: CP 254

Scope of Activity:

Design, manufacturing and test of multilayer chip ceramic capacitors

Issued by the Certification Body: LCIE Bureau Veritas

33 avenue, du Général Leclerc 92260, Fontenay aux Roses France

Authorized person: Gilles CUVILLIER







The validity of this certificate is maintained through on-going surveillance audits by the IECQ CB issuing this certificate.

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